On dose related issues in XFELs vs. ERLs

Outline:

- Motivation
- Overview of processes involved
- "Conventional" protein damage in crystallography
- Cryoprotected X-ray microscopy



Motivation

Biological and Environmental Research Advisory Committee (BERAC) at Department of Energy (DOE) meeting on April 30 - May 1 (2003) Washington, DC aims at addressing the following question from the Director of Office of Science

http://www.science.doe.gov/ober/berac/synchrotron.html

"What characteristics of the next generation x-ray light sources (e.g., their extremely short femtosecond time scale x-ray pulses; high average or peak brightness; coherence) are most important in enabling science, from determination of physical structures to biological functions, for the <u>biological community</u> in the coming 10-20 years?"

The response suggests (see <u>http://www.science.doe.gov/ober/berac/StructBio.pdf</u>):

... superiority of X-FELs over ERLs in "greater potential for breakdown science by <u>biological community</u>" (page 4). The reasoning behind this view is most succinctly recapped by the following phase that "ERLs will be far less powerful than X-FELs due to limited number of photons per ERL pulse" (page 16).



- Recap of radiation properties

	XFEL	ERL
Photons/pulse	10 ¹²	106-7
Rep. Rate [Hz]	10 ²	109
Pulse duration [ps]	0.1	0.1 – 2
Source size [µm]	30	10



- The scare of XFELs

- \bullet If focused to 10 μm spot, the peak power density is 10^{16} \, W/cm^2
- 200 kiloton nuclear weapon where 6% of the energy is emitted in X and γ rays over a time period of 100 ns creates peak photon density of 10^{17} W/cm² within the bomb casting
- $E \sim \sqrt{Z_0}I$, $Z_0 = 377 \Omega$, i.e. electric field ~ 10¹¹ V/m
- Coulomb field acting on an outer electron 10 V/ 1 Å ~ 10^{11} V/m
- <u>NOT</u> a strong field regime: $U_p = e^2 E^2 (\lambda^2 / 16\pi^2) / mc^2$, e.g. average kinetic energy of wiggling electron is only ~ 1 µeV
- OR amplitude of the wiggling motion is $a_w = 4U_p/eE \sim 5 \times 10^{-7}$ Angstrom

1 Å light oscillation takes only 0.3 attosecond



Processes involved



5

X-ray and electron processes

R.A. London et al, "Computational studies of high intensity X-ray matter interaction", Optics for Fourth Generation X-ray Sources, SPIE Proc (2001), 4500, p. 51





- Fluence [J/cm²] that matters

- for very short pulses (e.g. both XFELs and ERLs) it's fluence that matters
- XFEL: 10¹²×10keV ~ 1 mJ / pulse; ERL: 10⁶-10⁷×10keV ~ 10 nJ / pulse
- tolerable dose can be estimated as following (e.g. Si):
 - specific heat times 1700 300 K temperature difference
 - plus fusion heat, = 78 kJ/mole
 - normalized per atom ~ 0.8 eV/atom
- most elements have melting dose between 1/3 to 1 eV/atom
- < 0.1 eV/atom considered safe



Damage onset with instantaneous dose





Tolerable spot size for melting

Use protein density 0.8 Da/Å³

carbon photo-absorption cross-section $\sigma_a = 85$ barn/atom

```
dose per atom: E_{\rm pulse} \sigma_{\rm a} / area
```

For tolerable dose 0.1 - 1 eV/atom

XFEL ERL 10 – 30 µm 6* – 60 nm

For smaller spot sizes, one moves into a "single shot" regime

For high-Z materials this number is worse

* low flux regime



Explosive proteins

R. Neutze, et al., Nature, 406, 752-757, January 17, 2000



Very briefly: calculations were done for T4 lysozyme (diameter 32 Å, $N_{\rm C} \sim 1000$); flux 4×10⁶ X-rays/Å² with ~ 2000 primary ionization events; elastically scattered ~ 200 photons. The claim is that if pulse is sufficiently short (much shorter than the LCLS spec), 5×5×5 lysozyme nanocrystal will scatter to <2Å resolution.



Conventional damage to proteins

- Primary: breaking of chemical bonds
- Secondary: chemical damage by free radicals
- Tertiary: crystal lattice destabilized in absence of further chemical damage (domino effect)

cryoprotection helps with these two (prevents mass loss)

- Primary radiation dose 10⁷ Gy or ~200 X-rays/Angstrom² (Henderson's limit)
- It's accumulated dose that matters (unlike "fast melting")
- Despite the very different mechanisms, the damage dose is 1.4 eV/atom, very similar to the "single shot melting"
- Coulomb explosion requires much greater dose (delivered in a single pulse)



Disulphide bonds go first

M. Weik, et al., PNAS, Vol. 97, Issue 2, 623-628, January 18, 2000

Each frame is a complete data-set collected in about 3.5 minutes, each data-set is a 15 minutes time point. The left panel is the $3F_o$ - $2F_c$ map and model of the 254-265 disulfide bridge, and the right panel is the F_o - F_c map of the same S-S bond.







Cryoprotection prevents mass loss

T. Beetz and C. Jacobsen, J. Synchrotron Rad. (2003). 10, 280–283



Figure 2

(a) Coarse area scan at room temperature of a region that was dosed at room temperature. The square in the middle indicates the mass loss of the dosed region. (b) Coarse area scan at liquid-nitrogen temperature of the region that was dosed at liquid-nitrogen temperature. The image shows no visible mass loss at the dosed region. (c) Same area as that in image (b) but after warming up the sample; the dosed region becomes visible.

Radiation damage for ~ 10 nm resolution in cryoprotected X-ray microscopy is estimated to be at ~ 10^{10} Gy (~1 keV/atom ac. dose) [J. Maser et al., J. Microscopy (2000), **197**, p. 68]





Figure 4

(a) Loss of C=O peak intensity and (b) mass loss as a function of dose at liquid-nitrogen and room temperatures. The data were fitted using equations (2) and (3), where the fitting coefficients are summarized in Table 1.

Some preliminary conclusions

• Cryoprotection is likely to be ineffective for "single shot melting", i.e. X-ray microscopy is better off with c.w. source like an ERL

• Applications requiring multiple exposures of the same sample (e.g. tomography) with good resolution will prefer c.w. source over XFEL

• "single shot" experiments are for XFELs

• ...

